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Application/Control No.	Applicant(s)/Patent under Reexamination
10/648,424	HAJJ ET AL.
Examiner	Art Unit
Benny Q. Tieu	2614

SEARCHED					
Class	Subclass	Date	Examiner		
379	265.01- 266.1 309	11/8/2006	BQT		
709	223-227	11/8/2006	BQT		
	-				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
PGPUB Text Search, See Interference Search Printout		11/9/2006	BQT	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST	11/8/2006	вот
Interference Search History Printout	1/9/2006	вот
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